arch Note	25
arch Note	9



Application/Control No.	Applicant(s)/Patent under Reexamination
09/769,293	HINO ET AL.
Examiner	Art Unit

2876

Seung H. Lee

	SEARCHED				
Class	Subclass	Date	Examiner		
235	441	9/9/2007	SL		
235	436	9/9/2007	ŚL		
235	439	9/9/2007	SL		
235	451 ,	9/9/2007	SL		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Same as	Above	9/9/2007	SL
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
235/487,492,493	9/9/2007	SL .	
340/572.1	9/9/2007	SL	
EAST	9/9/2007	SL	
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